5-TAP, HCMOS-INTERFACED FIXED DELAY LINE (SERIES DDU4C)

data delay devices, inc. ®

FEATURES

- Five equally spaced outputs
- Fits standard 8-pin DIP socket
- Low profile
- Auto-insertable
- Input & outputs fully CMOS interfaced & buffered
- 10 T²L fan-out capability

PACKAGES

DIP

IN	1	14	VCC
		12	T1
T2	4		
		10	T3
T4	6		
GND	7	8	T5
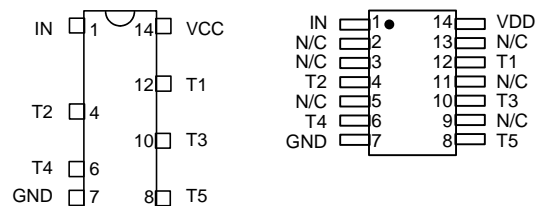
DDU4C-xx   Comm.
DDU4C-xxM Military

SMD

IN	1	14	VDD
N/C	2	13	N/C
N/C	3	12	T1
T2	4	11	N/C
N/C	5	10	T3
T4	6	9	N/C
GND	7	8	T5

DDU4C-xxA2   Comm.
DDU4C-xxB2   Comm.
DDU4C-xxMC2 Military

FUNCTIONAL DESCRIPTION

The DDU4C-series device is a 5-tap digitally buffered delay line. The signal input (IN) is reproduced at the outputs (T1-T5), shifted in time by an amount determined by the device dash number (See Table). The total delay of the line is measured from IN to T5. The nominal tap-to-tap delay increment is given by one-fifth of the total delay.

PIN DESCRIPTIONS

IN   Signal Input
T1-T5   Tap Outputs
VDD   +5 Volts
GND   Ground

SERIES SPECIFICATIONS

- **Minimum input pulse width:** 20% of total delay
- **Output rise time:** 8ns typical
- **Supply voltage:** 5VDC ± 5%
- **Supply current:** I_{CCL} = 40μa typical
  I_{CCH} = 10ma typical
- **Operating temperature:** 0° to 70° C
- **Temp. coefficient of total delay:** 300 PPM/°C

DASH NUMBER SPECIFICATIONS

Part Number	Total Delay (ns)	Delay Per Tap (ns)
DDU4C-5050	50 ± 2.5	10.0 ± 3.0
DDU4C-5060	60 ± 3.0	12.0 ± 3.0
DDU4C-5075	75 ± 4.0	15.0 ± 3.0
DDU4C-5100	100 ± 5.0	20.0 ± 3.0
DDU4C-5125	125 ± 6.5	25.0 ± 3.0
DDU4C-5150	150 ± 7.5	30.0 ± 3.0
DDU4C-5200	200 ± 10.0	40.0 ± 4.0
DDU4C-5250	250 ± 12.5	50.0 ± 5.0
DDU4C-5300	300 ± 15.0	60.0 ± 6.0
DDU4C-5400	400 ± 20.0	80.0 ± 8.0
DDU4C-5500	500 ± 25.0	100.0 ± 10.0

NOTE: Any dash number between 5050 and 5500 not shown is also available.
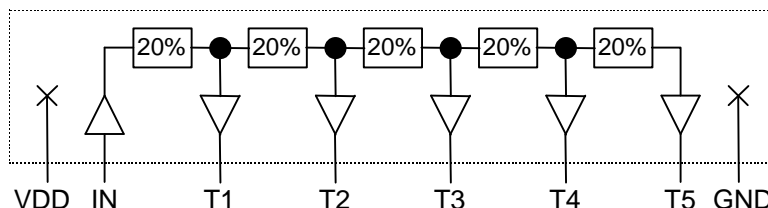
DDU4C Functional diagram

APPLICATION NOTES

HIGH FREQUENCY RESPONSE

The DDU4C tolerances are guaranteed for input pulse widths and periods greater than those specified in the test conditions. Although the device will function properly for pulse widths as small as 20% of the total delay and periods as small as 40% of the total delay (for a symmetric input), the delays may deviate from their values at low frequency. However, for a given input condition, the deviation will be repeatable from pulse to pulse. Contact technical support at Data Delay Devices if your application requires device testing at a specific input condition.

POWER SUPPLY BYPASSING

The DDU4C relies on a stable power supply to produce repeatable delays within the stated tolerances. A 0.1uf capacitor from VDD to GND, located as close as possible to the VDD pin, is recommended. A wide VDD trace and a clean ground plane should be used.

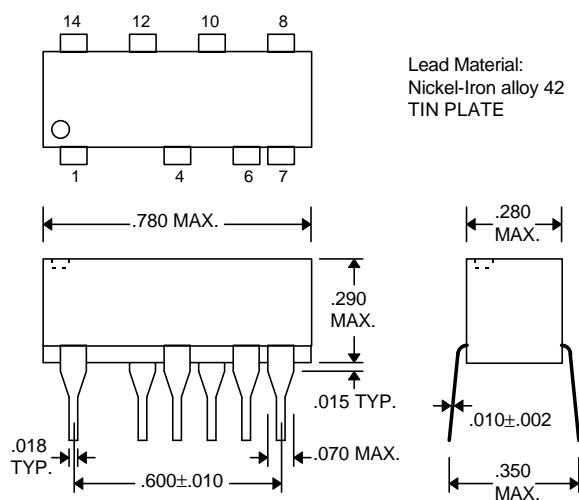# DEVICE SPECIFICATIONS

TABLE 1: ABSOLUTE MAXIMUM RATINGS

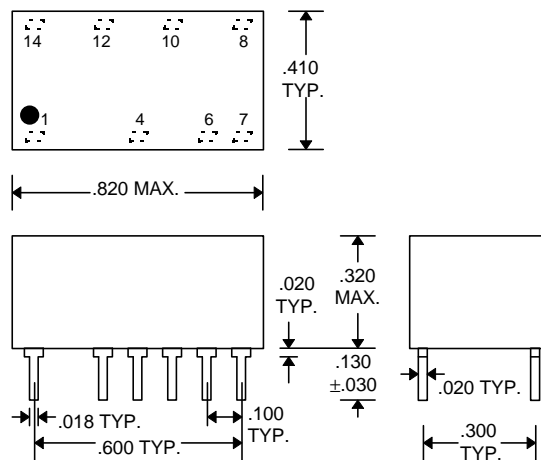| PARAMETER	SYMBOL	MIN	MAX	UNITS	NOTES
DC Supply Voltage	V_{DD}	-0.3	7.0	V	
Input Pin Voltage	V_{IN}	-0.3	V_{DD}+0.3	V	
Storage Temperature	T_{STRG}	-55	150	C	
Lead Temperature	T_{LEAD}		300	C	10 sec

TABLE 2: DC ELECTRICAL CHARACTERISTICS
(0C to 70C, 4.75V to 5.25V)

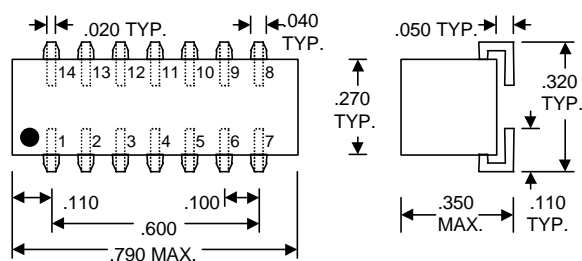| PARAMETER	SYMBOL	MIN	TYP	MAX	UNITS	NOTES
High Level Output Voltage	V_{OH}	3.98	4.4		V	V_{DD} = 5.0, I_{OH} = MAX V_{IH} = MIN, V_{IL} = MAX
Low Level Output Voltage	V_{OL}		0.15	0.26	V	V_{DD} = 5.0, I_{OL} = MAX V_{IH} = MIN, V_{IL} = MAX
High Level Output Current	I_{OH}			-4.0	mA	
Low Level Output Current	I_{OL}			4.0	mA	
High Level Input Voltage	V_{IH}	3.15			V	
Low Level Input Voltage	V_{IL}			1.35	V	
Input Current	I_{IH}			0.10	μA	V_{DD} = 5.0

PACKAGE DIMENSIONS

Lead Material:
Nickel-Iron alloy 42
TIN PLATE

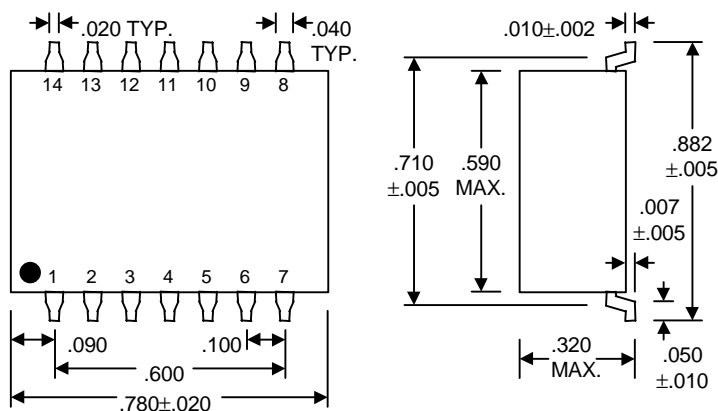**DDU4C-xx (Commercial DIP)**

DDU4C-xxM (Military DIP)
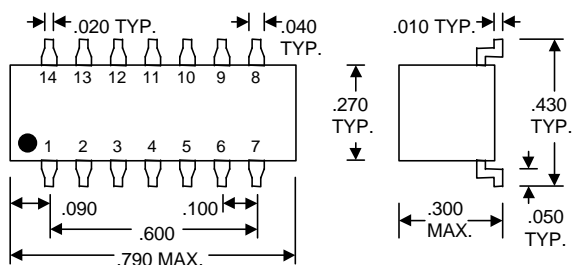
DDU4C-xxA2 (Commercial Gull-Wing)

DDU4C-xxB2 (Commercial J-Lead)

DDU4C-xxMC2 (Military SMD)

DELAY LINE AUTOMATED TESTING

TEST CONDITIONS

INPUT:

Ambient Temperature: $25^{\circ}C \pm 3^{\circ}C$
Supply Voltage (VDD): $5.0V \pm 0.1V$
Input Pulse: High = $5.0V \pm 0.1V$
Low = $0.0V \pm 0.1V$
Source Impedance: 50Ω Max.
Rise/Fall Time: 5.0 ns Max. (measured
between 0.5V and 4.5V)
Pulse Width: PW_{IN} = 1.5 x Total Delay
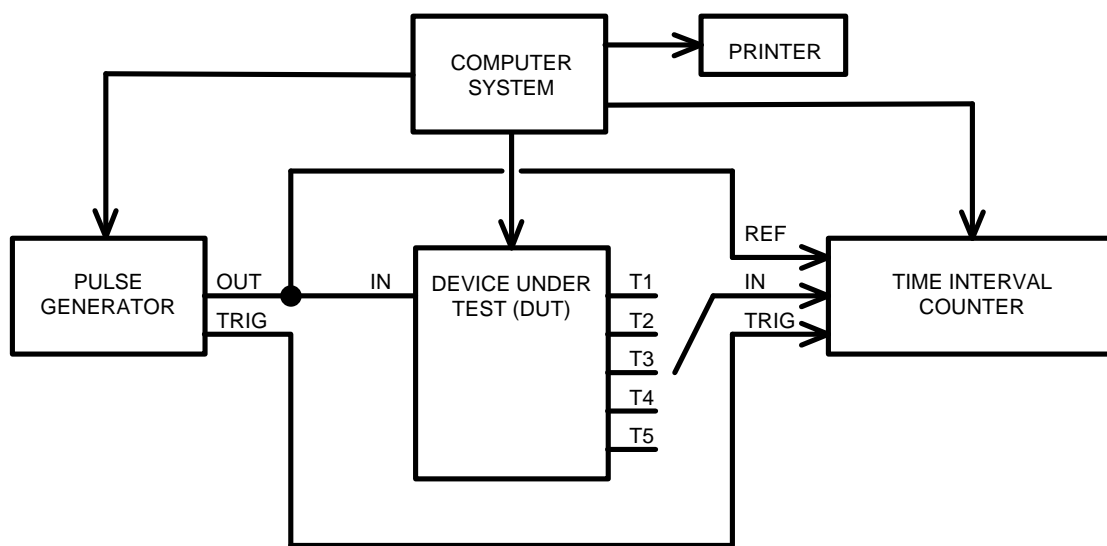**Period:** PER_{IN} = 10 x Total Delay
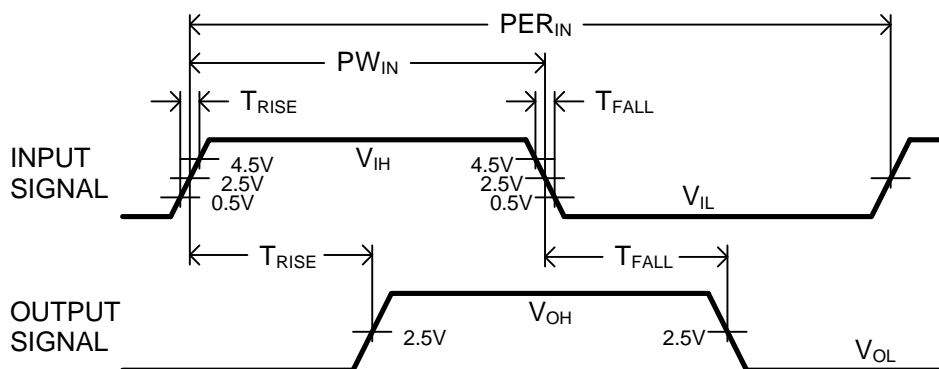
OUTPUT:

Load: 1 FAST-TTL Gate
C_{load}: 5pf $\pm$ 10%
Threshold: 2.5V (Rising & Falling)

NOTE: The above conditions are for test only and do not in any way restrict the operation of the device.

Test Setup

Timing Diagram For Testing